Power MOSFET

–20 V, –15 A, Single P–Channel, $\mu 8FL$

Features

- Ultra Low R_{DS(on)} to Minimize Conduction Losses
- µ8FL 3.3 x 3.3 x 0.8 mm for Space Saving and Excellent Thermal Conduction
- ESD Protection Level of 5 kV per JESD22-A114
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Battery Switch
- High Side Load Switch
- Optimized for Power Management Applications for Portable Products such as Media Tablets, Ultrabook PCs and Cellphones

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltage	V _{DSS}	-20	V		
Gate-to-Source Voltage	V _{GS}	±8	V		
Continuous Drain		$T_A = 25^{\circ}C$	۱ _D	-15	А
Current $R_{\theta JA}$ (Note 1)		$T_A = 85^{\circ}C$		-11	
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$	PD	2.3	W
Continuous Drain		$T_A = 25^{\circ}C$	I _D	-22	А
Current R _{θJA} ≤ 10 s (Note 1)	Steady	$T_A = 85^{\circ}C$		-16	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	State	$T_A = 25^{\circ}C$	P _D	4.9	W
Continuous Drain		$T_A = 25^{\circ}C$	Ι _D	-9	А
Current $R_{\theta JA}$ (Note 2)		$T_A = 85^{\circ}C$		-7	
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	P _D	0.84	W
Pulsed Drain Current	Pulsed Drain Current $T_A = 25^{\circ}C$, $t_p = 10 \ \mu s$				А
Operating Junction and S	T _J , T _{stg}	–55 to +150	°C		
ESD (HBM, JESD22-A1	V _{ESD}	5000	V		
Source Current (Body Di	۱ _S	-3	А		
Lead Temperature for So (1/8" from case for 10 s)	ΤL	260	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

2. Surface-mounted on FR4 board using the minimum recommended pad size.

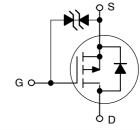


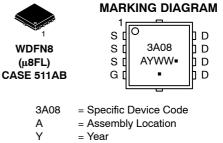
ON Semiconductor®

http://onsemi.com

V _{(BR)DSS} R _{DS(on)} MAX		I _D MAX
–20 V	$6.7~\mathrm{m}\Omega$ @ $-4.5~\mathrm{V}$	–15 A
	9.0 mΩ @ -2.5 V	-137









= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]		
NTTFS3A08PZTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel		
NTTFS3A08PZTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel		

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	55	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	148	
Junction-to-Ambient – (t \leq 10 s) (Note 3)	$R_{\theta JA}$	26	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size (40 mm², 1 oz. Cu).

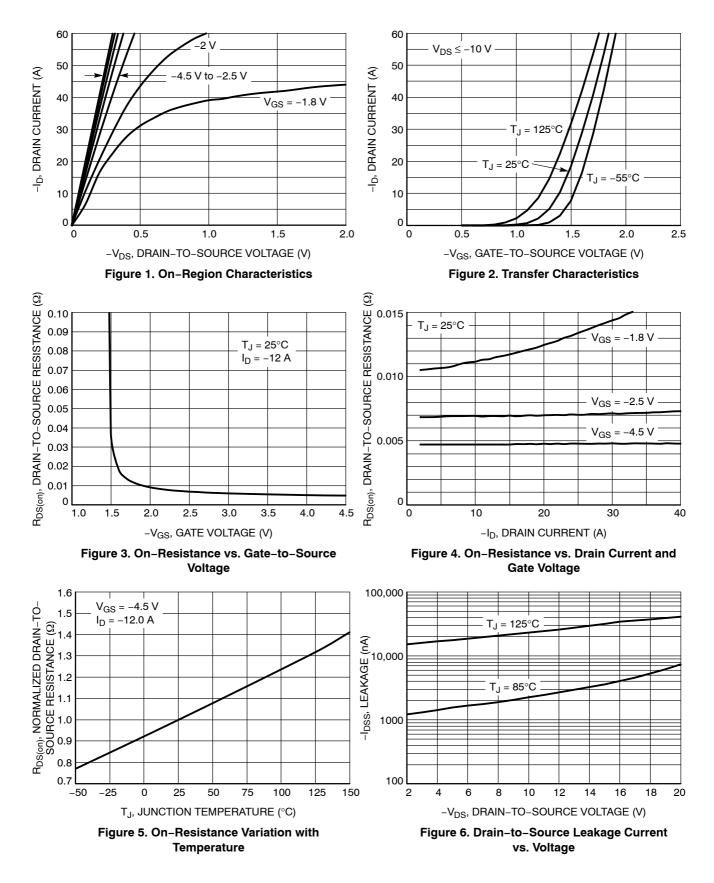
ELECTRICAL CHARACTERISTICS (T.I = 25°C unless otherwise specified)

Parameter	Symbol	Test Conditi	on	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 µA		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				6		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = -16 V	$T_J = 25^{\circ}C$			-1	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS} =	= ±5 V			±5	μA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -$	-250 μA	-0.4		-1.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.3		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -4.5 V	I _D = -12 A		4.9	6.7	mΩ
		V _{GS} = -2.5 V	I _D = -10 A		6.9	9.0	
Forward Transconductance	9 _{FS}	$V_{DS} = -1.5 \text{ V}, \text{ I}_{D} = -8 \text{ A}$			62		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = -10 V			5000		pF
Output Capacitance	C _{oss}				600		
Reverse Transfer Capacitance	C _{rss}				540		
Total Gate Charge	Q _{G(TOT)}				56		nC
Threshold Gate Charge	Q _{G(TH)}				2.0		
Gate-to-Source Charge	Q _{GS}	V _{GS} = -4.5 V, V _{DS} = -1	0 V, I _D = -8 A		6.5		
Gate-to-Drain Charge	Q _{GD}				15.4		
SWITCHING CHARACTERISTICS (Note	e 6)						
Turn-On Delay Time	t _{d(on)}				13		ns
Rise Time	t _r	V_{GS} = -4.5 V, V_{DS} = -10 V, I_{D} = -8 A, R_{G} = 6.0 Ω			60]
Turn-Off Delay Time	t _{d(off)}				250		
Fall Time	t _f				170		
DRAIN-SOURCE DIODE CHARACTER	ISTICS				-	•	-
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V,$ $I_{S} = -3 A$	$T_J = 25^{\circ}C$		-0.65	-1.0	V
		1	1		I	I	+

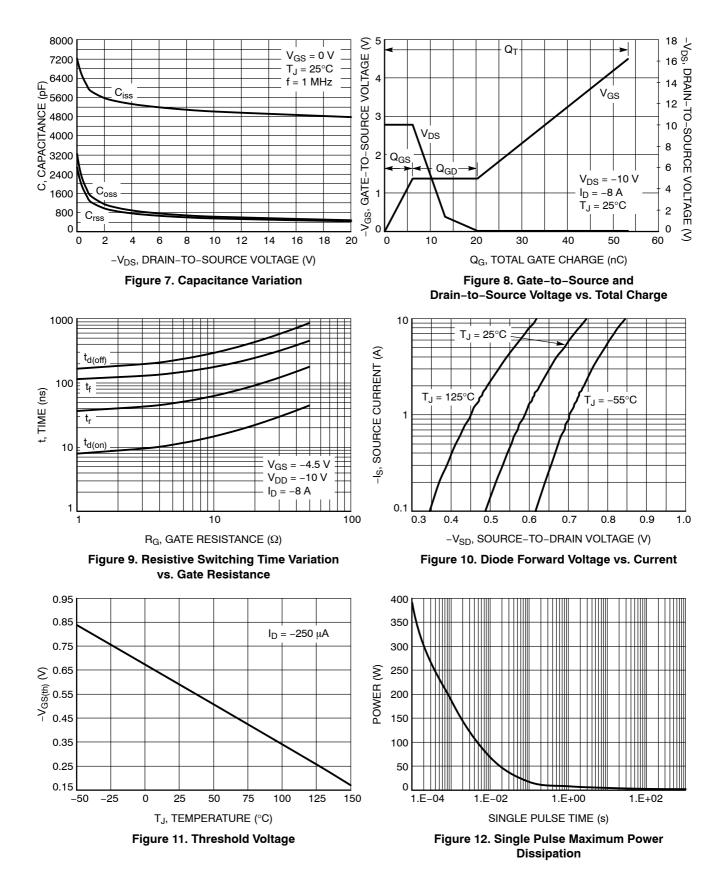
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = –3 A	$T_{\rm J} = 25^{\circ}C$	-0.65	-1.0	V
Reverse Recovery Time	t _{RR}			207		ns
Charge Time	t _a	V_{GS} = 0 V, d_{IS}/d_t = 100 A/µs, I_S = –6 A		45		
Discharge Time	t _b			162		
Reverse Recovery Charge	Q _{RR}			234		nC

5. Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

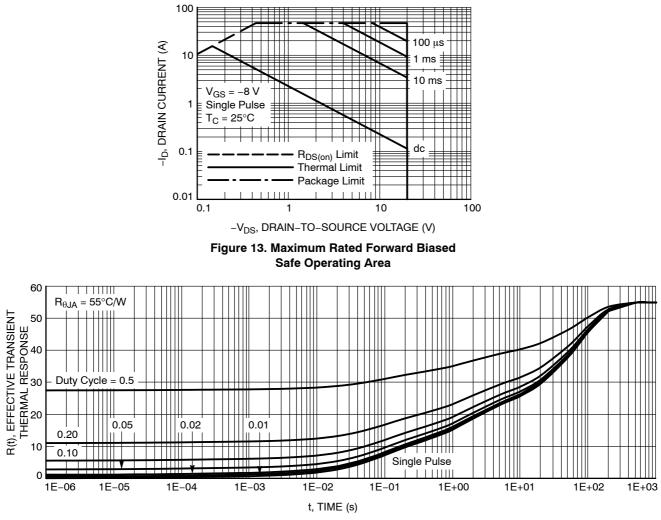
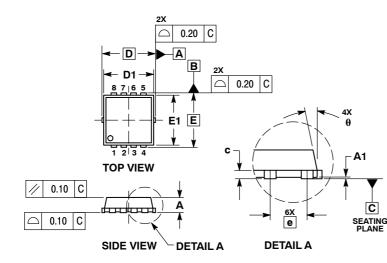


Figure 14. FET Thermal Response

PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D



8X b В С A 0.10 ¢ 0.05 С e/2 4X E2 м F3 ¥ D2 G **BOTTOM VIEW**

NOTES:

3

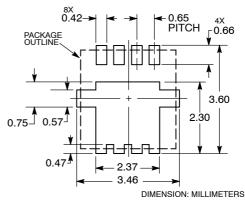
DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2

CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH

PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
c	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		0.130 BSC			
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
Е	;	3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC		0.026 BSC		2	
G	0.30	0.41	0.51	0.012	0.016	0.020	
ĸ	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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